

# Operational Experience of the LHC RADiation MONitoring (RADMON) System

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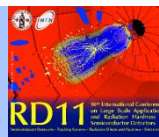
*On behalf of the RadMON project, CERN, Geneva, Switzerland*

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Hardness of Semiconductor Detectors**

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**07/07/11 – RD11 conference**



# Outline

- I. Radiation Monitoring project
- II. Radiation monitoring sensors
- III. Benchmark for Fluka simulations
- IV. RadMON Software
- V. Application
  - *LHC operation*
  - *Experimental test areas (CNRAD and H4IRRAD)*
- VI. Conclusion

# Radiation monitoring project

## ● Radiation monitoring project at CERN : Why ?

● The effect of radiation on electronic components and systems → **Major issue**

● Equipments → **Affected by radiation damage**

→ *Radiation level survey needed for damage and failure analysis.*

● **Considerable uncertainty** on the radiation environment in the tunnel and on the radiation tolerance of equipment..

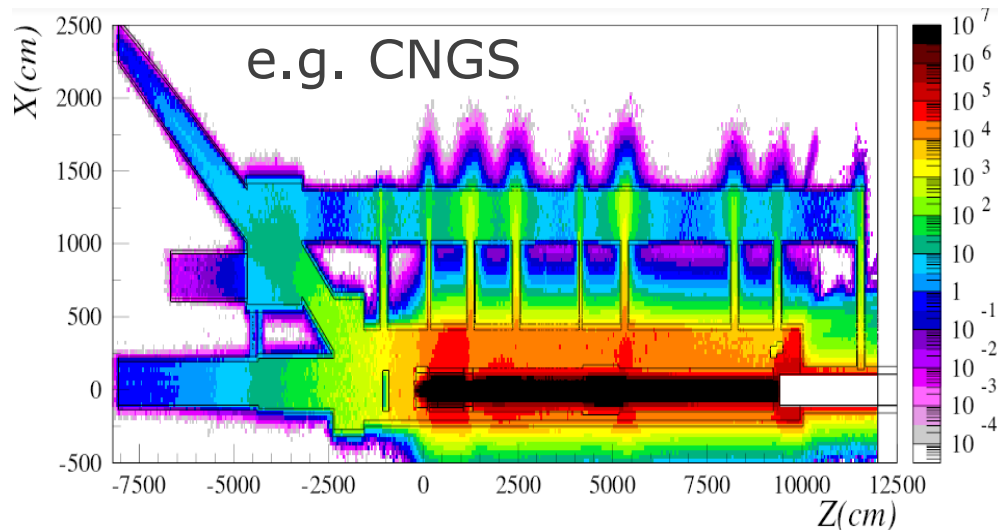
● The radiation monitoring system will help to **reduce this uncertainty by providing an early warning** as the radiation levels at the location of the equipment increase.

● **Motivation:** Provide essential feedback on the LHC radiation levels in critical area (based on simulations)

● Estimation of the evolution of radiation levels while LHC intensities/luminosities increase.

# Radiation monitoring project

## ● Radiation monitoring project at CERN : What ?



### Ionization effect

TID (Total Ionizing Dose)

e.g. accumulation of charge in  $\text{SiO}_2$  : *damage to microelectronic components*

### Non-Ionizing effect

NIEL (Non Ionizing Energy Loss)

causing e.g. crystal defects in semiconductor crystals

### **Cumulative effects**

### Single event effect

Single Event Transients (SET), Latchup (SEL), Burnout (SEB),

Gate Rupture (SEGR), Upset (SEU)

e.g. bit flip in SRAM memories (SEU)

### **Stochastic effect**

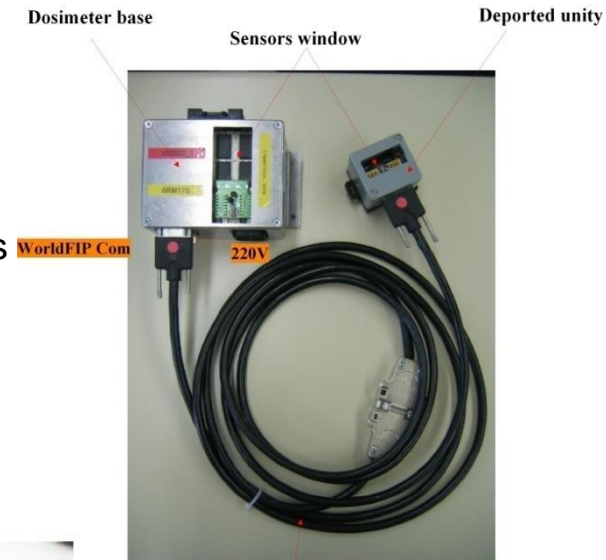
# Radiation monitoring project

## ● Radiation monitoring project at CERN : How ?

### ● RADMON on WorldFip bus:

- About 400 devices installed in the LHC tunnel and in the shielded galleries
- 1s rate measurement over the field bus WorldFip  
(TID, 1 MeV neutron eq. fluence, HEH and thermal neutron fluence)

RADMON



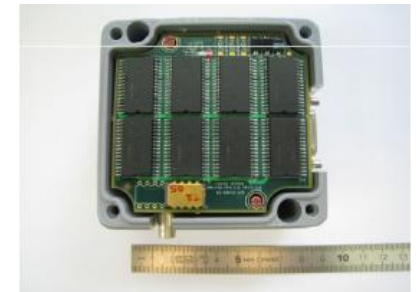
### ● RADMON battery driven → BATMON

- To measure single spot where field bus is not available
- Off line reading (TID, HEH fluence and 1 MeV neutron eq. fluence)

BATMON



Communication main > deported sensors  
3.6m to 200m

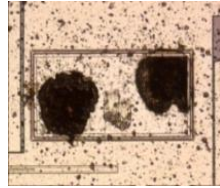


- Very stable system including several hundred of monitors
- Fullfills specific LHC requirements
- Can be applied to a much larger context

# Radiation monitoring sensors

Radiation damage in semiconductors

Single Events



Effect in the Device

Displacement

Dose



SEU counter

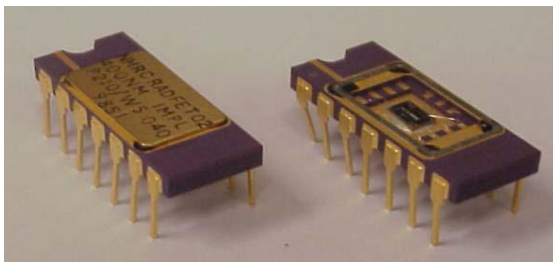
Toshiba memory AF

Effect in the Device



PIN diodes

RadFETs

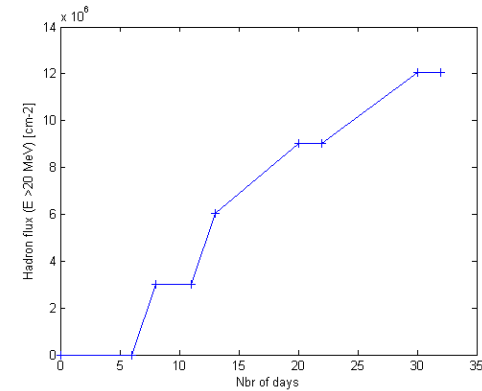


# Radiation monitoring sensors

## Static RAM

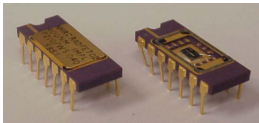


- Measure radiation induced voltage spikes over reversed bias p-n junction
- Number of “0-1” in SRAM proportional to the hadron fluence.
- Measurement at 3 V and 5 V allows to estimate HEH and the thermal neutrons fluence<sup>1,2</sup>.



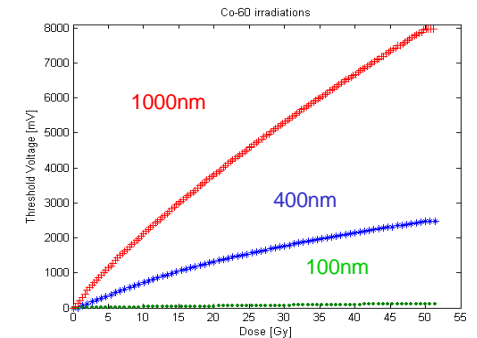
<sup>1</sup> For more details on the estimation please refer to **D. Kramer et al. “Radecs 2010 proceedings”**.

<sup>2</sup> Calibration study will be presented by “**K. Roed et al. at Radecs 2011 conference**”.



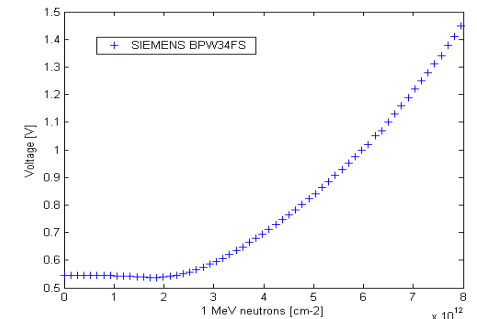
## RadFET

- Measure trapped charge in gate oxide (SiO<sub>2</sub>)
- At constant current:  $\Delta V$  proportional to Total Ionizing Dose (TID)
- Different oxide thicknesses → different sensitivities

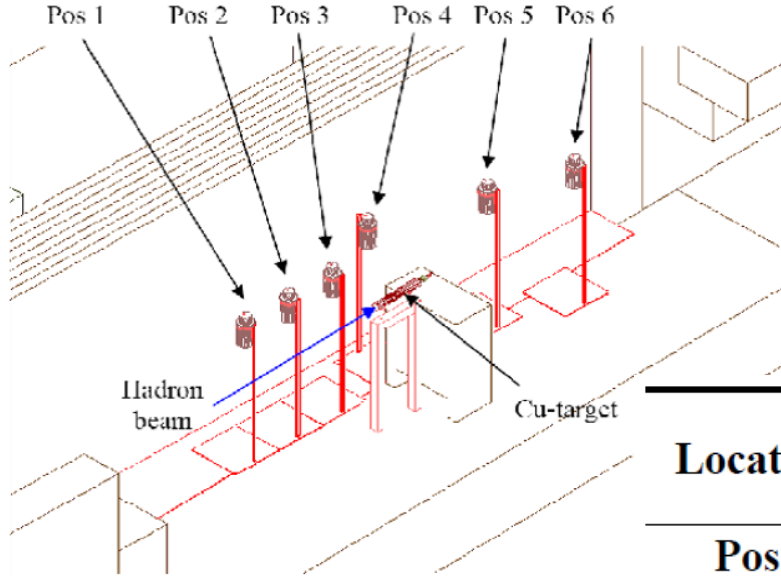


## P-I-N diode

- At constant current:  $\Delta V$  proportional to 1 MeV eq. Neutron fluence ( $\Phi_{eq}$ )
- Measure conductivity variation at high forward injection



# Fluka/RadMON Benchmark



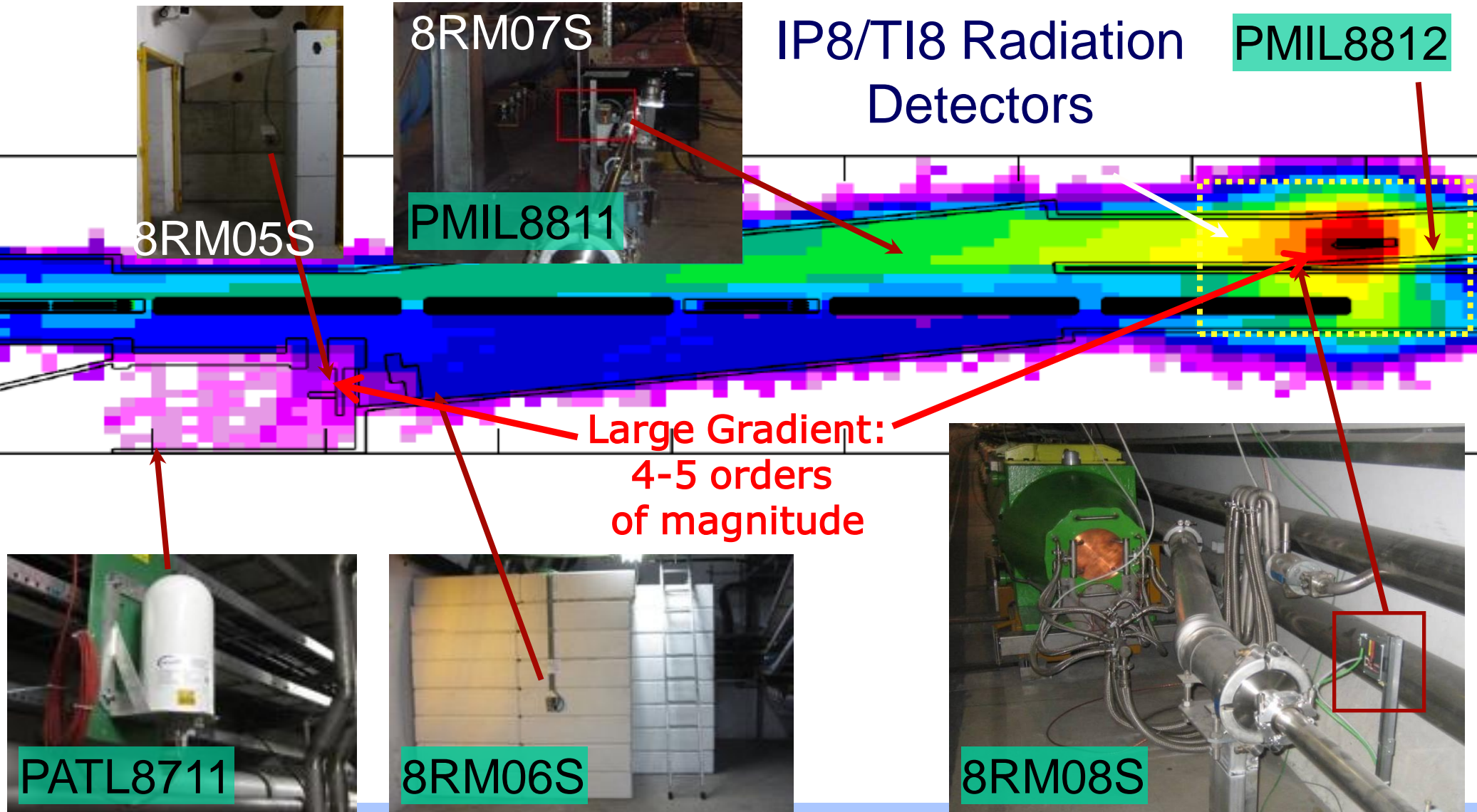
## ● CERF Benchmark

Location	RadMon [Error]	FLUKA [Error]	Ratio (R/F)
Pos1	$3.77 \times 10^{-4}$ [20.0%]	$4.17 \times 10^{-4}$ [5.1%]	0.90
Pos2	$5.76 \times 10^{-4}$ [20.0%]	$5.76 \times 10^{-4}$ [4.6%]	1.00
Pos3	$1.99 \times 10^{-3}$ [20.0%]	$1.97 \times 10^{-3}$ [2.8%]	1.04
Pos4	$1.75 \times 10^{-3}$ [20.0%]	$1.71 \times 10^{-3}$ [3.4%]	1.02
Pos5	$1.53 \times 10^{-3}$ [20.0%]	$1.67 \times 10^{-3}$ [3.2%]	0.92
Pos6	$2.19 \times 10^{-3}$ [20.0%]	$2.19 \times 10^{-3}$ [2.9%]	1.00

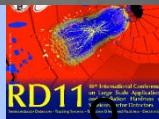
M. Brugger et al., "FLUKA CAPABILITIES AND CERN APPLICATIONS FOR THE STUDY OF RADIATION DAMAGE TO ELECTRONICS AT HIGH-ENERGY HADRON ACCELERATORS", presented at the "Monte-Carlo Conference 2010 in Tokyo", accepted for publication in "Progress in Nuclear Science and Technology", PNST10184-R1 (2010).



# Fluka/RadMON Benchmark



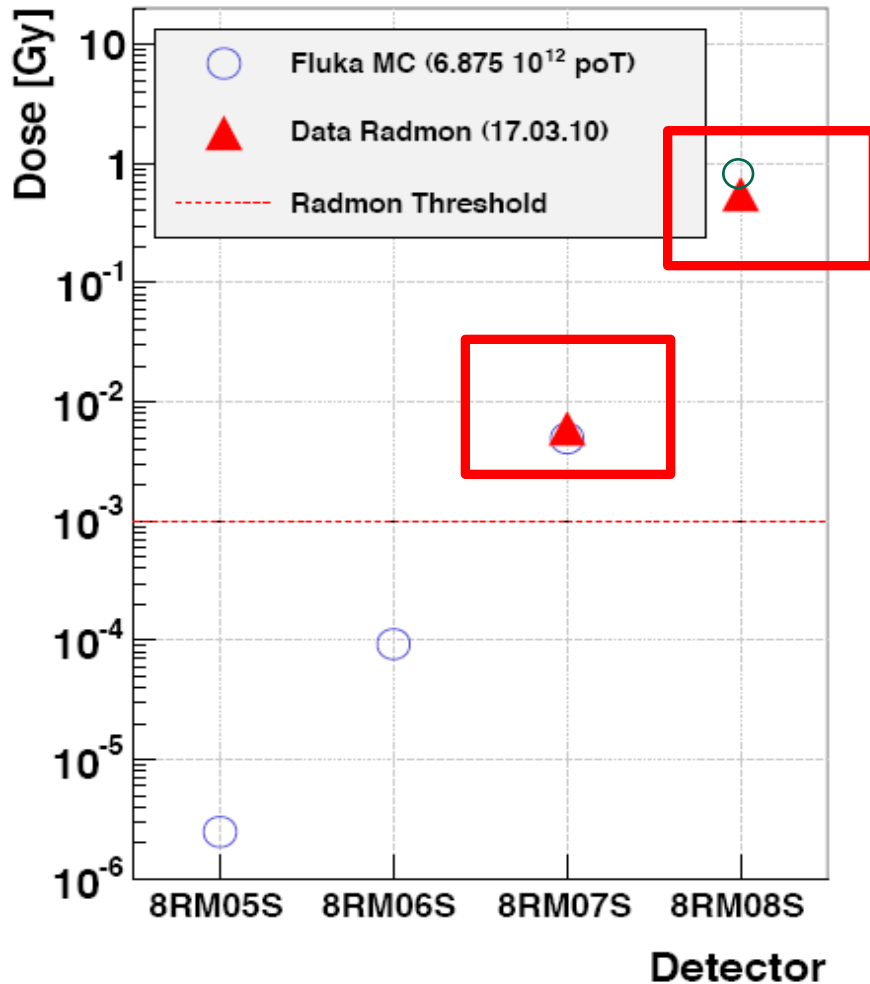
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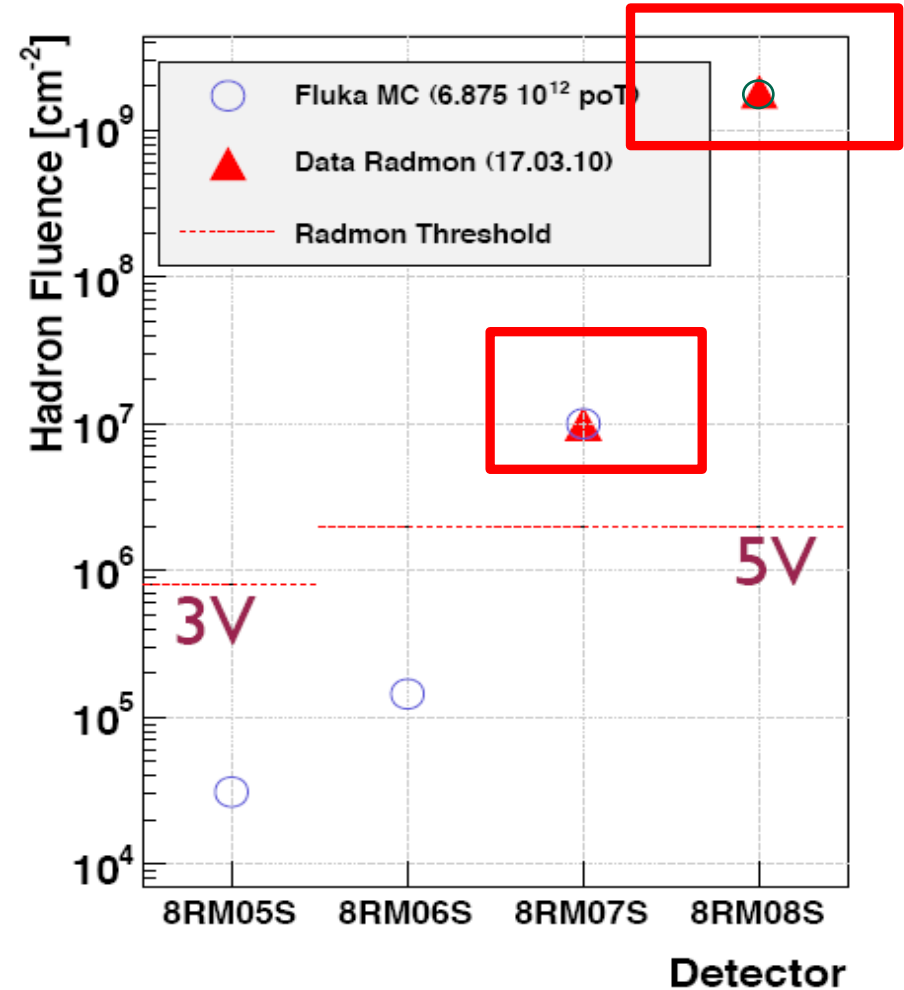
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# Fluka/RadMON Benchmark

Dose in UJ87/UJ88 - Radmon and Ramses



Hadron Fluence in UJ87/UJ88 - Radmon and Ramses



# RadMON Software

## • *Calibration database*

### What is it ?

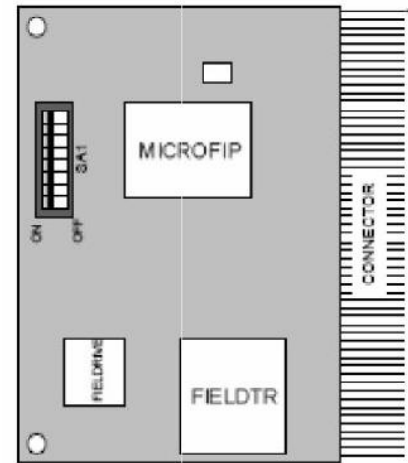
- A web application designed to store configuration data for RadMon devices.
- Provides tools for viewing multiple/specific RadMon devices.
- Generates the configuration files for RadMon FESA system.

### Why do we need it ?

- Single point of data storage
- Reduces generation time and potential for inconsistencies when generating configuration files.
- Accessible from entire CERN network

# RadMON Software

- *RadMON FIP Library*
- Software library to communicate with RadMON devices via WorldFIP bus
  - Initialize devices
  - read/write commands
  - status information
- Read characteristics of radiation devices in a device's location
- Provides external applications with API to
  - Configure protocol
  - Operate on devices
  - Access partially interpreted data
- Provides direct access to device via toolset
  - RadMON monitor
    - Direct access to calibrated device data
  - RadMON raw data monitor
    - For diagnostic purpose



WorldFIP - MicroFIP interface<sup>3</sup>

<sup>3</sup> <http://cern-worldfip.web.cern.ch/cern-worldfip/docs.php>

# Application

## ◆ LHC operation: **Main objectives during circulating beam in LHC ?**

- ◆ Monitor the radiation field → degradation of electronics due to radiation when beam “on”
- ◆ Correlate observed failures with respective radiation levels, e. g. during abnormal beam losses:
  - ◆ Propose appropriate radiation tolerant components in case of radiation induced failures
  - ◆ Anticipate replacement of electronics that degraded due to cumulative radiation damage effects

◆ Collimation, radiation in RRs due to collision products, ...

◆ Measure shielding efficiency – confirm staged implementation

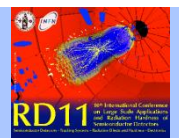
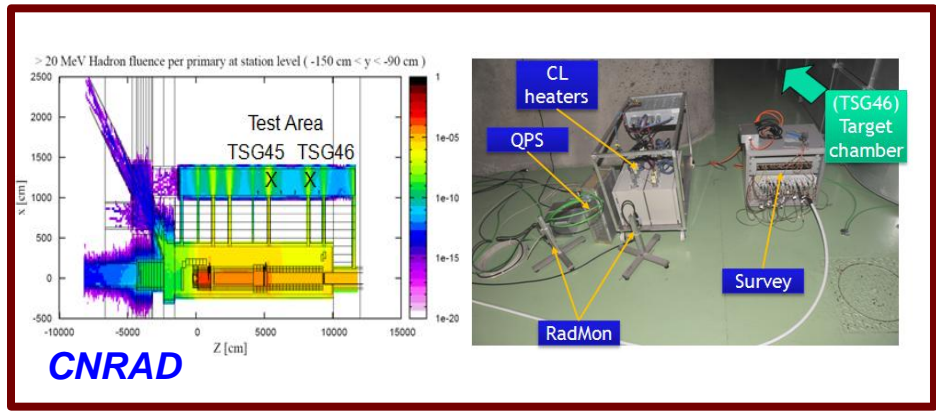
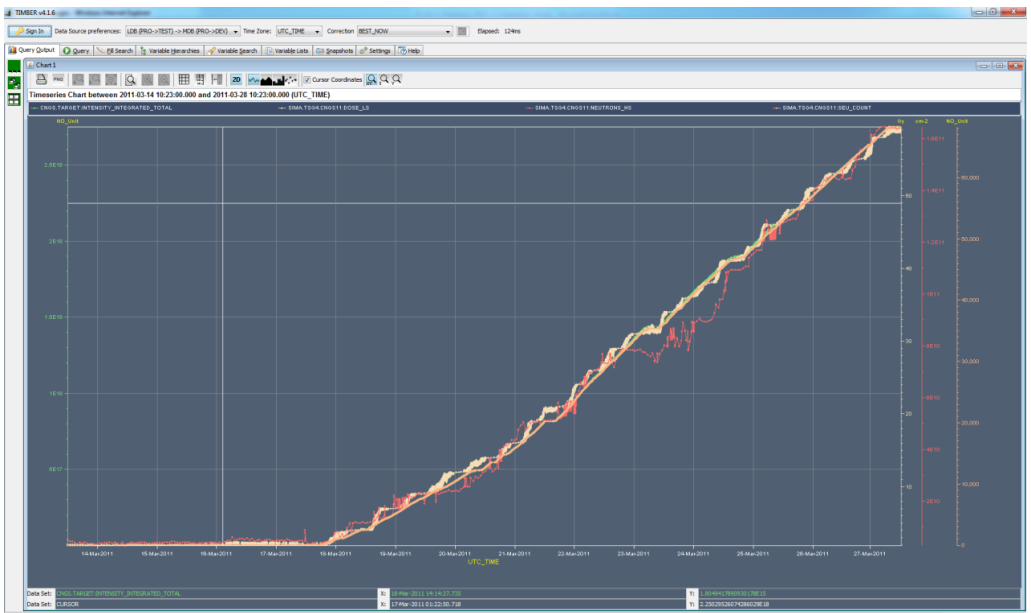
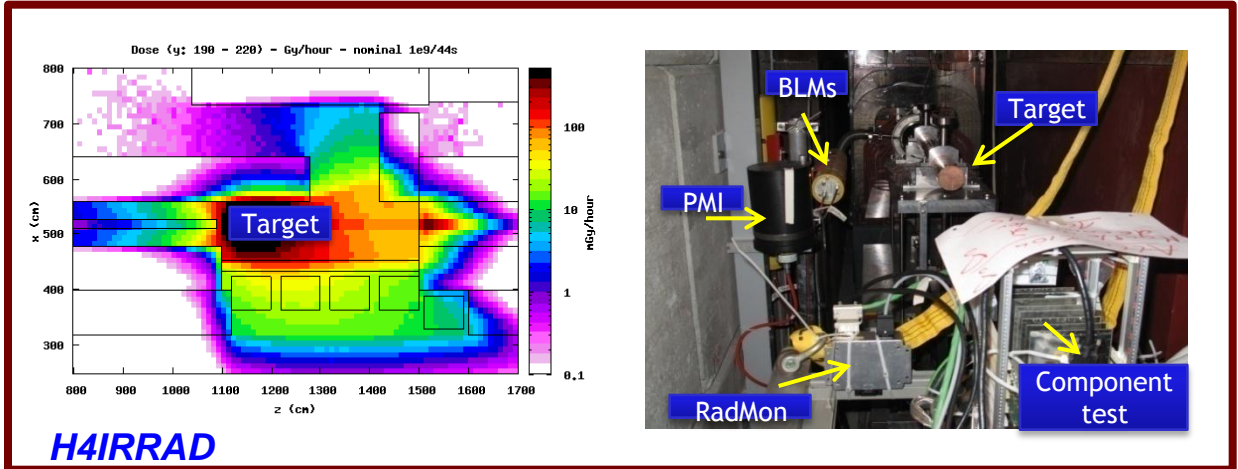
◆ Cross check with simulation results

RadMON



# Application

- **Experimental test Areas**
- RadMONs are installed in **CERN radiation facilities and tests areas** (CERF, CNRAD, H4IRRAD)
- Monitoring of the mixed field for the equipment under test
- Continuous reiteration to improve the calibration (cross check with other sensors BLM, PMI, and benchmark for simulations)



# Conclusion

- A Radiation monitoring system has been developed at CERN.
- [Fluka/RadMON benchmark](#) is performed for LHC locations and experimental test areas.
- [RadFETs and p-i-n diode](#) dosimeters are used for monitoring TID and  $\Phi_{eq}$  respectively.
- [SRAM memories](#) are used for monitoring the HEH fluence and well as the thermal neutrons fluence.
- A [RadMON software](#) has been designed:
  - To communicate with the RadMONs via a WorldFIP field bus.
  - To configure the RadMON Fesa system & visualize the data remotely via tools available on the CERN network.  
(e. g. Timber)
- A [Battery system](#) has been developed to access zone where no field bus are available.
- Used in the [LHC accelerator](#) as well as in [radiation facilities and experimental test areas](#).